Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10520310	VAN DER MARK ET AL.
Examiner	Art Unit

2627

SEARCHED			
Class	Subclass	Date	Examiner

HENOK G HEYI

SEARCH NOTES		
Search Notes	Date	Examiner
searched class 369/13.13, 13.17, 13.18, 13.19 and 13.33 - text search only (see search history printout) and also consulted primary Tan Dinh.	11/29/2007	HH
Updated search.	07/24/2008	HH
Conducted more search on EAST.	12/05/2008	HH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HENOK G HEYI/ Examiner.Art Unit 2627	

U.S. Patent and Trademark Office Part of Paper No.: 20081205